

**Notice of References Cited**Application/Control No.  
**09/735,645**Applicant(s)/Patent Under Reexam  
**Shin**Examiner  
**Nabil Hindi**Art Unit  
**2655**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	6,357,030	12/1998	Demura et al	369	47.33
B	5,970,208	6/1997	Shim	386	126
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**NON-PATENT DOCUMENTS**

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